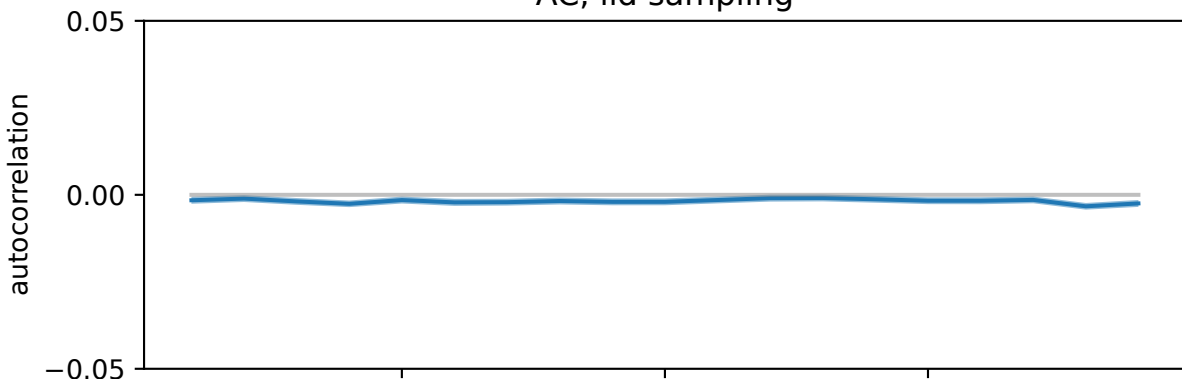
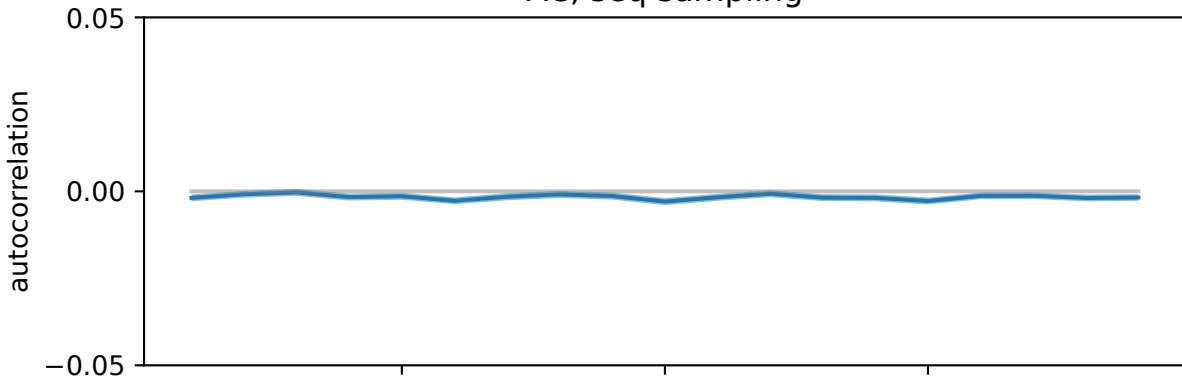


top-down likelihood

AC, iid sampling



AC, seq sampling



difference in AC

